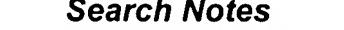


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/558,205	KIRSCH ET AL.
	Examiner /Shean C. Wu/	Art Unit 1756

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner